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900V GaN FET in TO-220 (source tab)

Description

The TP90H180PS 900V, 170mΩ Gallium Nitride (GaN) FET is a normally-off device. It combines state-of-the-art high voltage GaN HEMT and low voltage silicon MOSFET technologies—offering superior reliability and performance.

Transphorm GaN offers improved efficiency over silicon, through lower gate charge, lower crossover loss, and smaller reverse recovery charge.

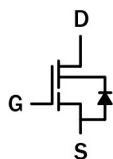
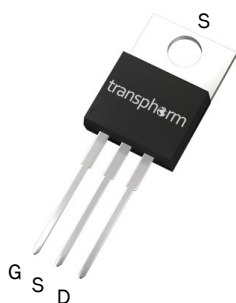
Related Literature

- [AN0009](#): Recommended External Circuitry for GaN FETs
- [AN0003](#): Printed Circuit Board Layout and Probing
- [AN0010](#): Paralleling GaN FETs

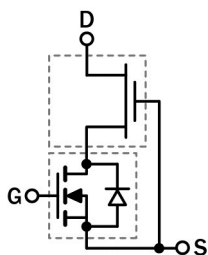
Ordering Information

Part Number	Package	Package Configuration
TP90H180PS	3 lead TO-220	Source

TP90H180PS
TO-220
(top view)



Cascode Schematic Symbol



Cascode Device Structure

Features

- JEDEC qualified GaN technology
- Dynamic $R_{DS(on)eff}$ production tested
- Robust design, defined by
 - Intrinsic lifetime tests
 - Wide gate safety margin
 - Transient over-voltage capability
- Very low Q_{RR}
- Reduced crossover loss
- RoHS compliant and Halogen-free packaging

Benefits

- Enables AC-DC bridgeless totem-pole PFC designs
 - Increased power density
 - Reduced system size and weight
 - Overall lower system cost
- Achieves increased efficiency in both hard- and soft-switched circuits
- Easy to drive with commonly-used gate drivers
- GSD pin layout improves high speed design

Applications

- Datacom
- Broad industrial
- PV inverter
- Servo motor

Key Specifications	
V_{DSS} (V)	900
$V_{(TR)DSS}$ (V)	1000
$R_{DS(on)eff}$ (mΩ) max*	205
Q_{RR} (nC) typ	49
Q_G (nC) typ	10

* Dynamic on-resistance; see Figures 19 and 20

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Absolute Maximum Ratings (T_c=25 °C unless otherwise stated.)

Symbol	Parameter	Limit Value	Unit
V _{DSS}	Drain to source voltage (T _J = -55 °C to 150 °C)	900	V
V _{(TR)DSS}	Transient drain to source voltage ^a	1000	
V _{GSS}	Gate to source voltage	±18	
P _D	Maximum power dissipation @T _c =25 °C	78	W
I _D	Continuous drain current @T _c =25 °C ^b	15	A
	Continuous drain current @T _c =100 °C ^b	10	A
I _{DM}	Pulsed drain current (pulse width: 10µs)	58	A
(di/dt) _{RDMC}	Reverse diode di/dt, repetitive ^c	1200	A/µs
(di/dt) _{RDMT}	Reverse diode di/dt, transient ^d	2400	A/µs
T _C	Operating temperature	Case	-55 to +150 °C
T _J		Junction	-55 to +150 °C
T _S	Storage temperature	-55 to +150	°C
T _{SOLD}	Soldering peak temperature ^e	260	°C

Notes:

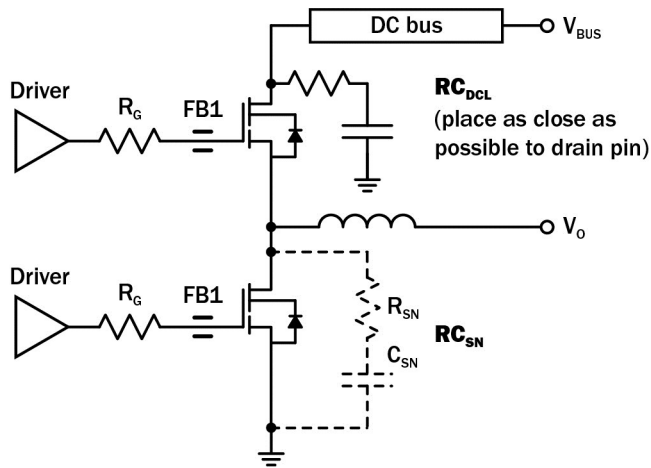
- In off-state, spike duty cycle D<0.01, spike duration <1µs
- For increased stability at high current operation, see Circuit Implementation on page 3
- Continuous switching operation
- ≤300 pulses per second for a total duration ≤20 minutes
- For 10 sec., 1.6mm from the case

Thermal Resistance

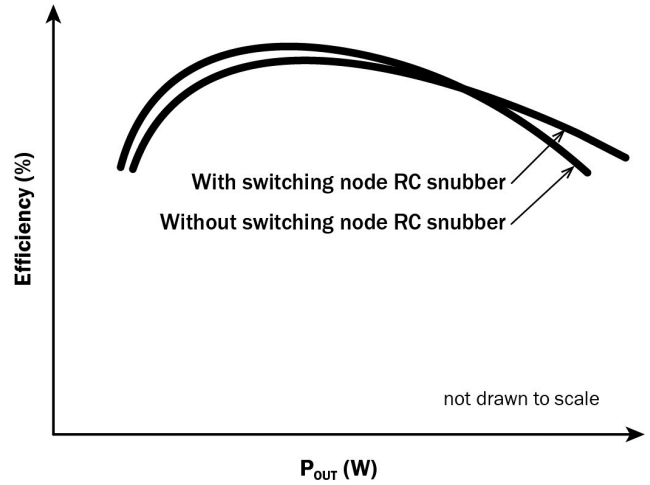
Symbol	Parameter	Typical	Unit
R _{θJC}	Junction-to-case	1.6	°C/W
R _{θJA}	Junction-to-ambient	62	°C/W

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Circuit Implementation



Simplified Half-bridge Schematic



Efficiency vs Output Power

Recommended gate drive: (0V, 8-10V) with $R_{G(tot)} = 25\Omega$, where $R_{G(tot)} = R_G + R_{DRIVER}$

Gate Ferrite Bead (FB1)	Required DC Link RC Snubber (RC_{DCL}) ^a	Recommended Switching Node RC Snubber (RC_{SN}) ^{b, c}
MMZ1608Q121BTA00	10nF + 8 Ω	22pF + 15 Ω

Notes:

- RC_{DCL} should be placed as close as possible to the drain pin
- A switching node RC snubber (C, R) is recommended for high switching currents (>70% of I_{RDMC1} or I_{RDMC2} ; see page 5 for I_{RDMC1} and I_{RDMC2})
- I_{RDM} values can be increased by increasing R_G and C_{SN}

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Electrical Parameters (T_J=25 °C unless otherwise stated)

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
Forward Device Characteristics						
V _{(BL)DSS}	Drain-source voltage	900	—	—	V	V _{GS} =0V
V _{GS(th)}	Gate threshold voltage	1.6	2.1	2.6	V	V _{DS} =V _{GS} , I _D =0.5mA
R _{DS(on)eff}	Drain-source on-resistance ^a	—	170	205	mΩ	V _{GS} =10V, I _D =10A
		—	350	—		V _{GS} =10V, I _D =10A, T _J =150 °C
I _{DSS}	Drain-to-source leakage current	—	2.5	30	μA	V _{DS} =900V, V _{GS} =0V
		—	12	—		V _{DS} =900V, V _{GS} =0V, T _J =150 °C
I _{GSS}	Gate-to-source forward leakage current	—	—	100	nA	V _{GS} =18V
		—	—	-100		V _{GS} =-18V
C _{ISS}	Input capacitance	—	780	—	pF	V _{GS} =0V, V _{DS} =600V, f=1MHz
C _{OSS}	Output capacitance	—	41	—		
C _{RSS}	Reverse transfer capacitance	—	5	—		
C _{O(er)}	Output capacitance, energy related ^b	—	54	—	pF	V _{GS} =0V, V _{DS} =0V to 600V
C _{O(tr)}	Output capacitance, time related ^c	—	88	—		
Q _G	Total gate charge	—	10	—	nC	V _{DS} =600V, V _{GS} =8V, I _D =10A
Q _{GS}	Gate-source charge	—	2.6	—		
Q _{GD}	Gate-drain charge	—	2.9	—		
Q _{OSS}	Output charge	—	53	—	nC	V _{GS} =0V, V _{DS} =0V to 600V
t _{D(on)}	Turn-on delay	—	26	—	ns	V _{DS} =600V, V _{GS} =8V, I _D =10A, R _G =22Ω
t _R	Rise time	—	5	—		
t _{D(off)}	Turn-off delay	—	40	—		
t _F	Fall time	—	7.4	—		

Notes:

- Dynamic on-resistance; see Figures 19 and 20 for test circuit and conditions
- Equivalent capacitance to give same stored energy as V_{DS} rises from 0V to 600V
- Equivalent capacitance to give same charging time as V_{DS} rises from 0V to 600V

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Electrical Parameters (T_J=25 °C unless otherwise stated)

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
Reverse Device Characteristics						
I _S	Reverse current	—	—	9.5	A	V _{GS} =0V, T _C =100 °C, ≤25% duty cycle
V _{SD}	Reverse voltage ^a	—	2.3	—	V	V _{GS} =0V, I _S =10A
		—	1.6	1.9		V _{GS} =0V, I _S =5A
t _{RR}	Reverse recovery time	—	32	—	ns	I _S =10A, V _{DD} =600V, di/dt=1000A/μs
Q _{RR}	Reverse recovery charge	—	49	—	nC	
(di/dt) _{RDMC}	Reverse diode di/dt, repetitive ^b	—	—	1200	A/μs	
I _{RDMC1}	Reverse diode switching current, repetitive (dc) ^{c, e}	—	—	11	A	Circuit implementation and parameters on page 3
I _{RDMC2}	Reverse diode switching current, repetitive (ac) ^{c, e}	—	—	14	A	Circuit implementation and parameters on page 3
(di/dt) _{RDMT}	Reverse diode di/dt, transient ^d	—	—	2400	A/μs	
I _{RDMT}	Reverse diode switching current, transient ^{d, e}	—	—	18	A	Circuit implementation and parameters on page 3

Notes:

- Includes dynamic R_{DS(on)} effect
- Continuous switching operation
- Definitions: dc = dc-to-dc converter topologies; ac = inverter and PFC topologies, 50-60Hz line frequency
- ≤300 pulses per second for a total duration ≤20 minutes
- I_{RDM} values can be increased by increasing R_G and C_{SN} on page 3

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Typical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise stated)

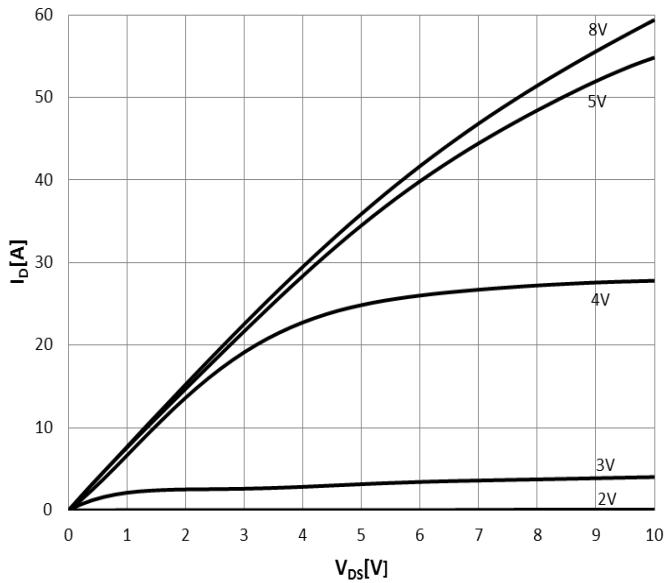


Figure 1. Typical Output Characteristics $T_J=25^\circ\text{C}$
Parameter: V_{GS}

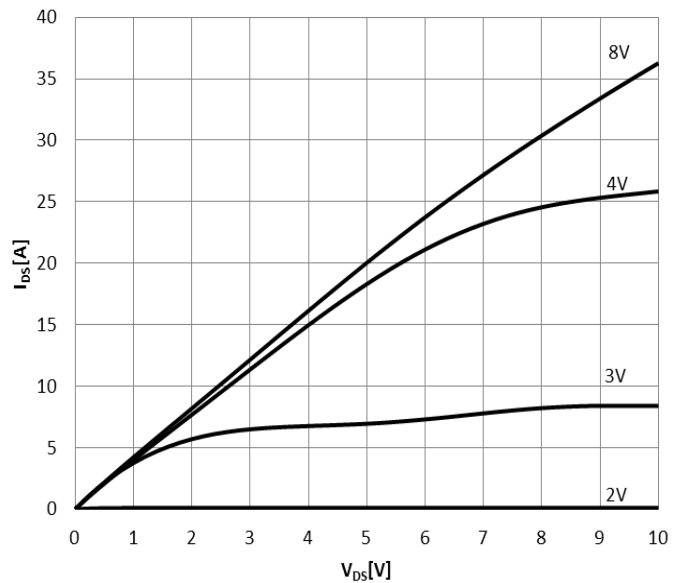


Figure 2. Typical Output Characteristics $T_J=150^\circ\text{C}$
Parameter: V_{GS}

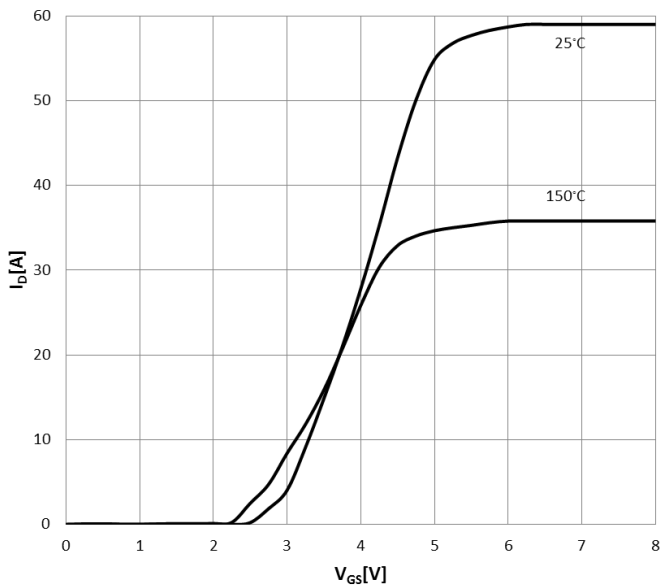


Figure 3. Typical Transfer Characteristics
 $V_{DS}=10\text{V}$, parameter: T_J

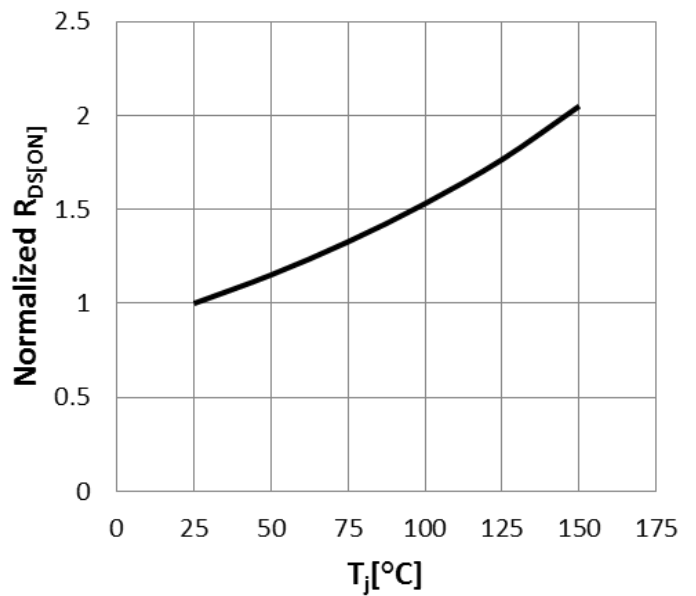


Figure 4. Normalized On-resistance
 $I_D=10\text{A}$, $V_{GS}=8\text{V}$

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Typical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise stated)

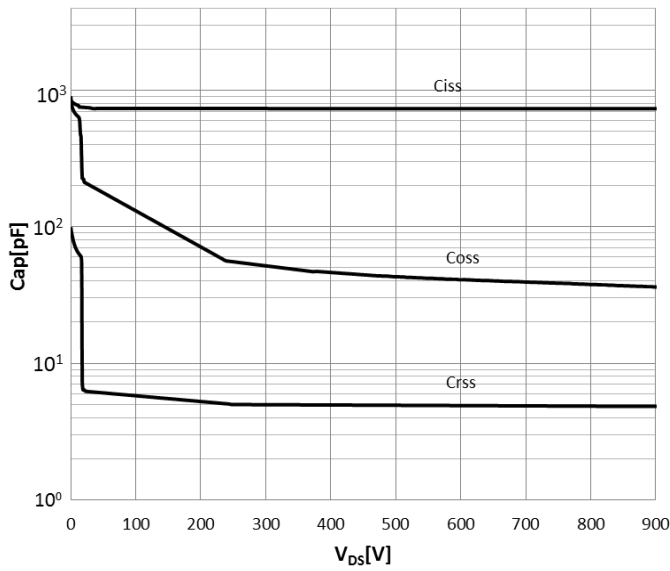


Figure 5. Typical Capacitance

$V_{GS}=0V$, $f=1\text{MHz}$

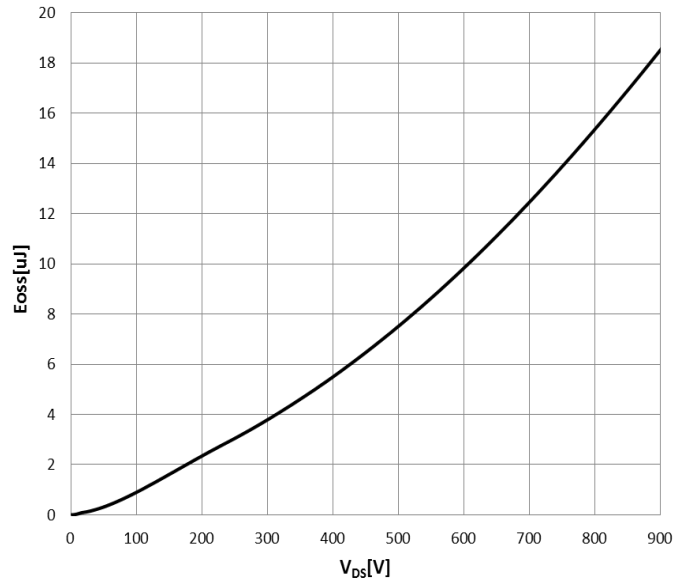


Figure 6. Typical C_{oss} Stored Energy

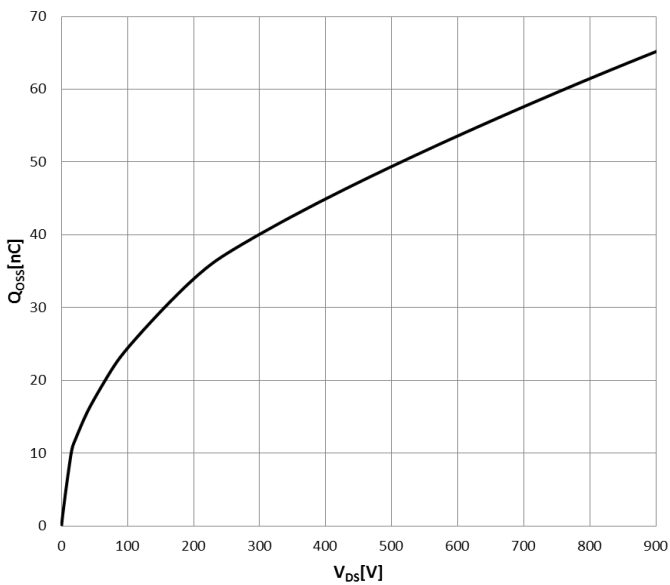


Figure 7. Typical Q_{oss}

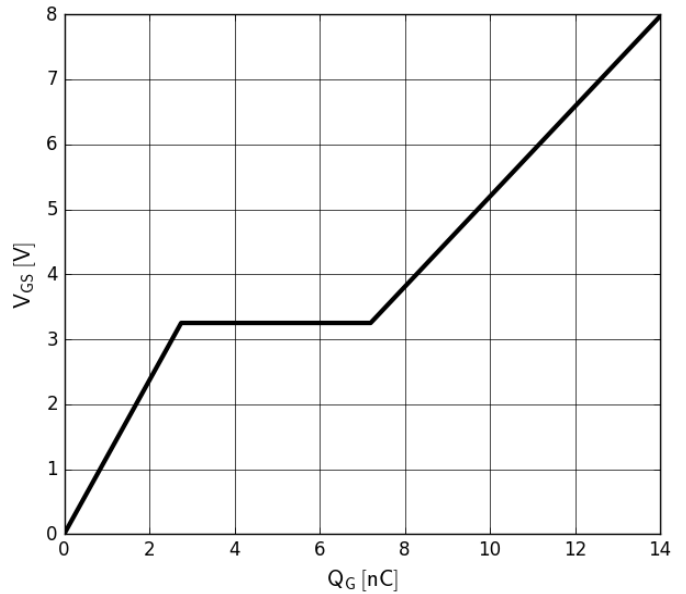


Figure 8. Typical Gate Charge

$I_{DS}=10A$, $V_{DS}=600V$

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Typical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise stated)

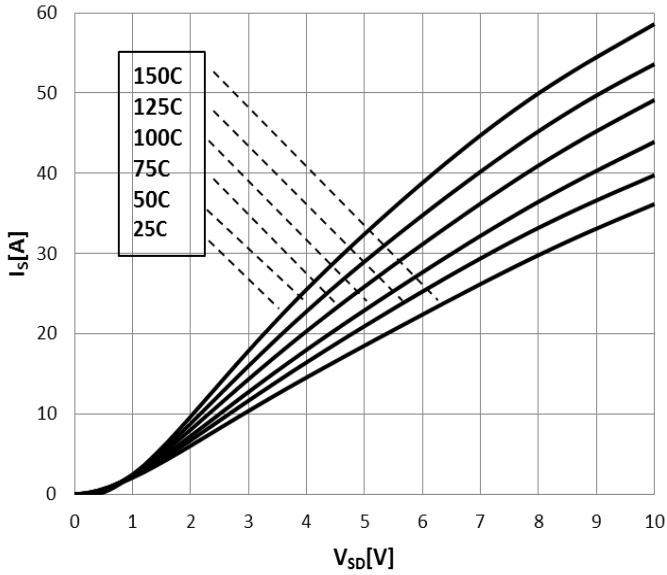


Figure 9. Forward Characteristics of Rev. Diode
 $I_s=f(V_{sd})$, parameter T_J

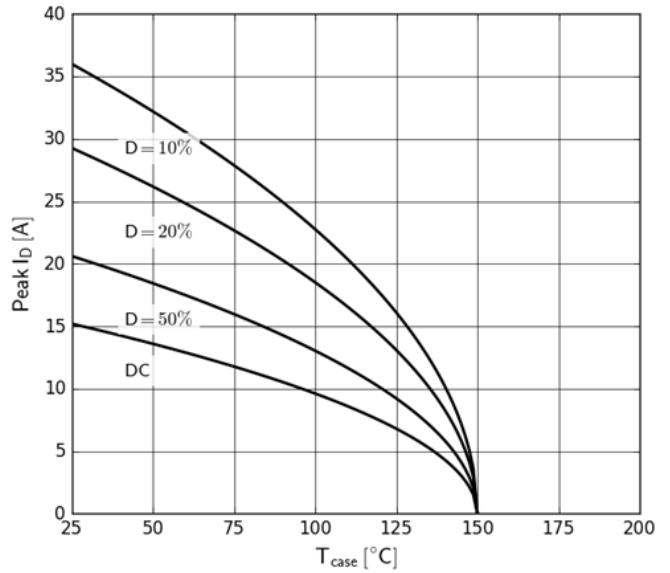


Figure 10. Current Derating
 Pulse width = $100\mu\text{s}$

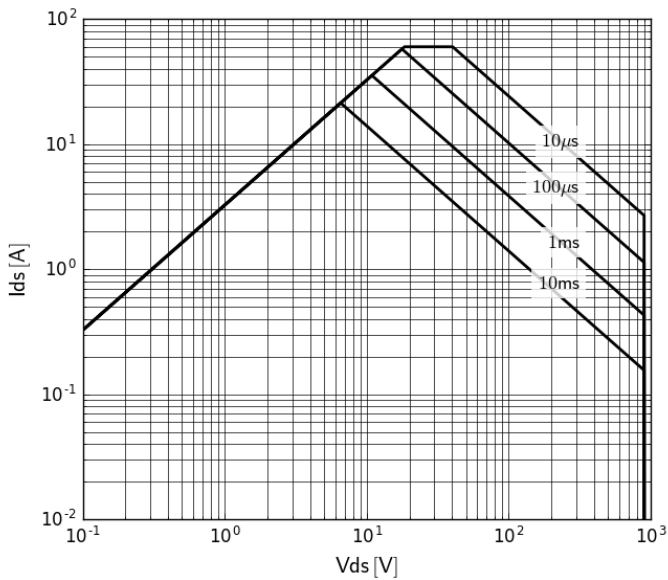


Figure 11. Safe Operating Area $T_c=25^\circ\text{C}$
 (calculated based on thermal limit)

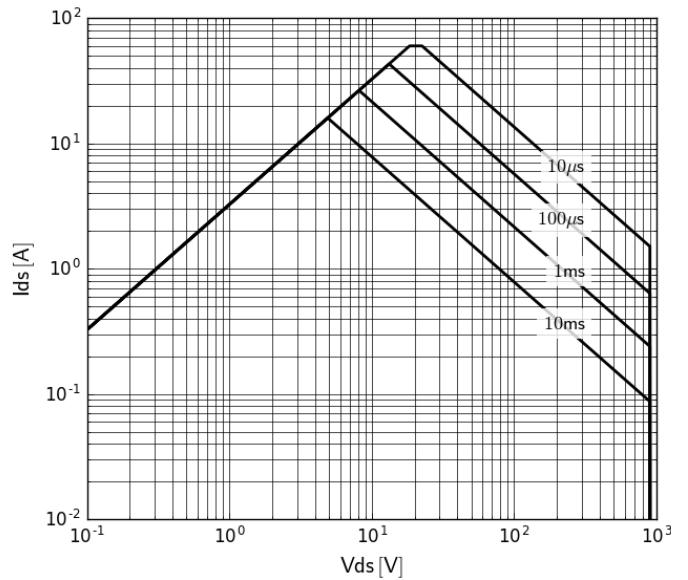


Figure 12. Safe Operating Area $T_c=80^\circ\text{C}$
 (calculated based on thermal limit)

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Typical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise stated)

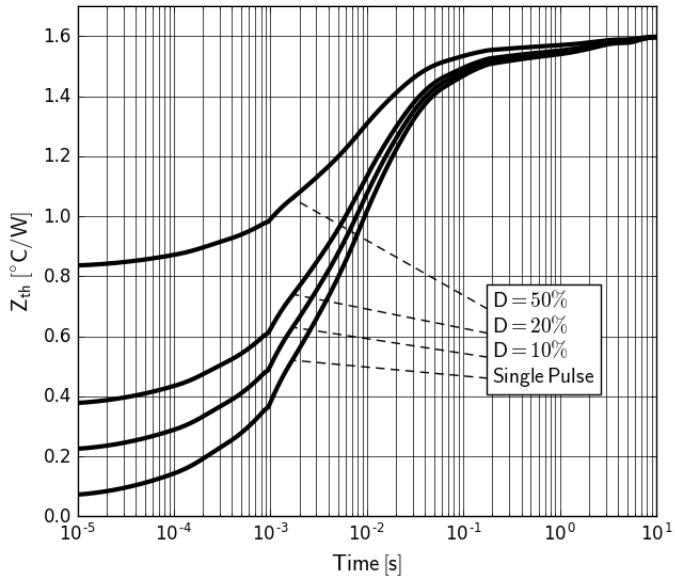


Figure 13. Transient Thermal Resistance

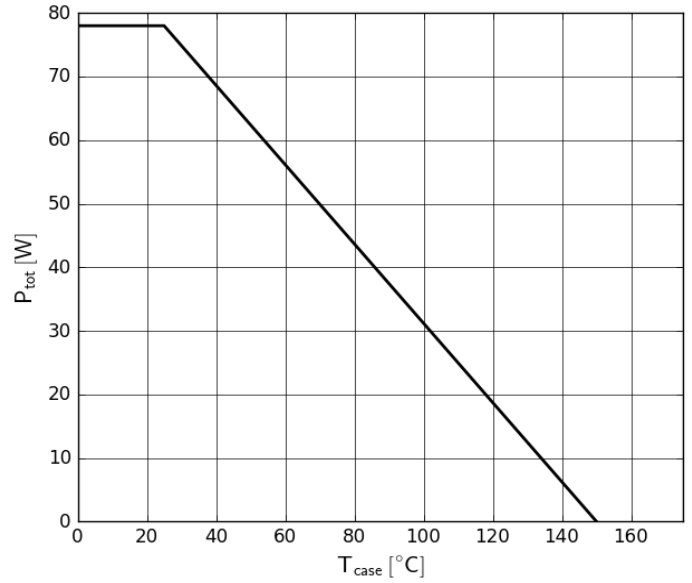


Figure 14. Power Dissipation

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Test Circuits and Waveforms

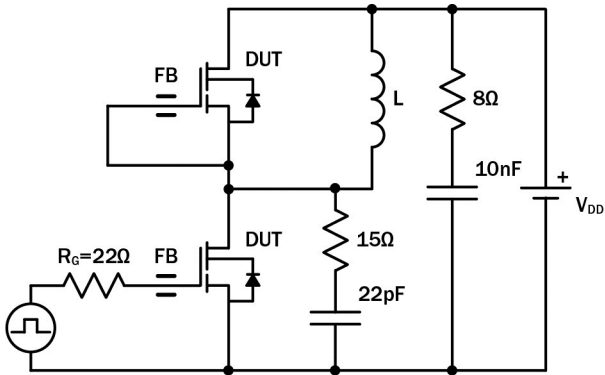


Figure 15. Switching Time Test Circuit
(see circuit implementation on page 3 for methods to ensure clean switching)

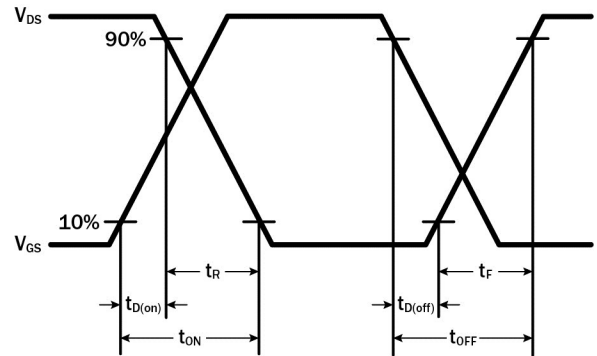


Figure 16. Switching Time Waveform

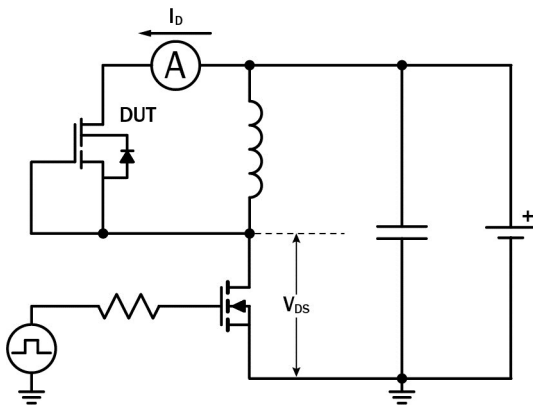


Figure 17. Diode Characteristics Test Circuit

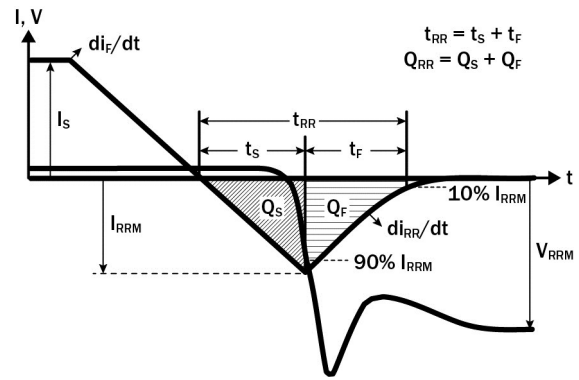


Figure 18. Diode Recovery Waveform

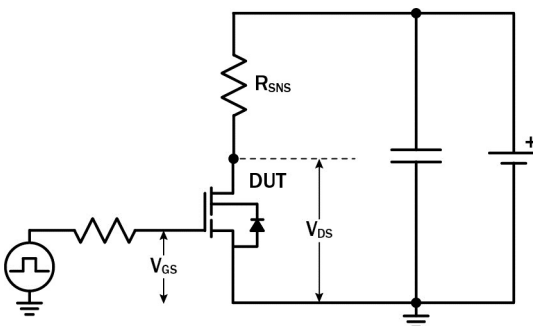


Figure 19. Dynamic $R_{DS(on)eff}$ Test Circuit

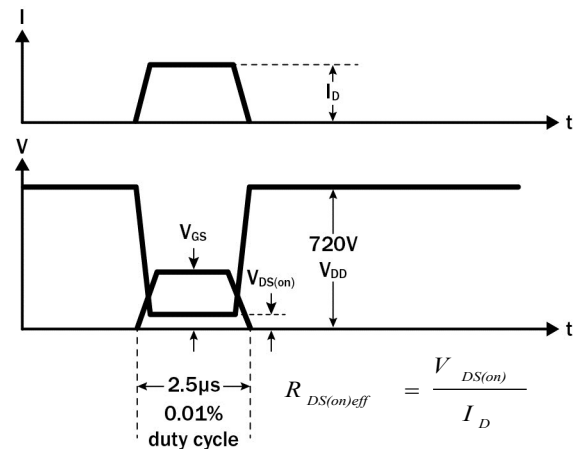


Figure 20. Dynamic $R_{DS(on)eff}$ Waveform

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Design Considerations

The fast switching of GaN devices reduces current-voltage crossover losses and enables high frequency operation while simultaneously achieving high efficiency. However, taking full advantage of the fast switching characteristics of GaN switches requires adherence to specific PCB layout guidelines and probing techniques.

Before evaluating Transphorm GaN devices, see application note [Printed Circuit Board Layout and Probing for GaN Power Switches](#). The table below provides some practical rules that should be followed during the evaluation.

When Evaluating Transphorm GaN Devices:

DO	DO NOT
Minimize circuit inductance by keeping traces short, both in the drive and power loop	Twist the pins of TO-220 or TO-247 to accommodate GDS board layout
Minimize lead length of TO-220 and TO-247 package when mounting to the PCB	Use long traces in drive circuit, long lead length of the devices
Use shortest sense loop for probing; attach the probe and its ground connection directly to the test points	Use differential mode probe or probe ground clip with long wire
See AN0003 : Printed Circuit Board Layout and Probing	

GaN Design Resources

The complete technical library of GaN design tools can be found at transphormusa.com/design:

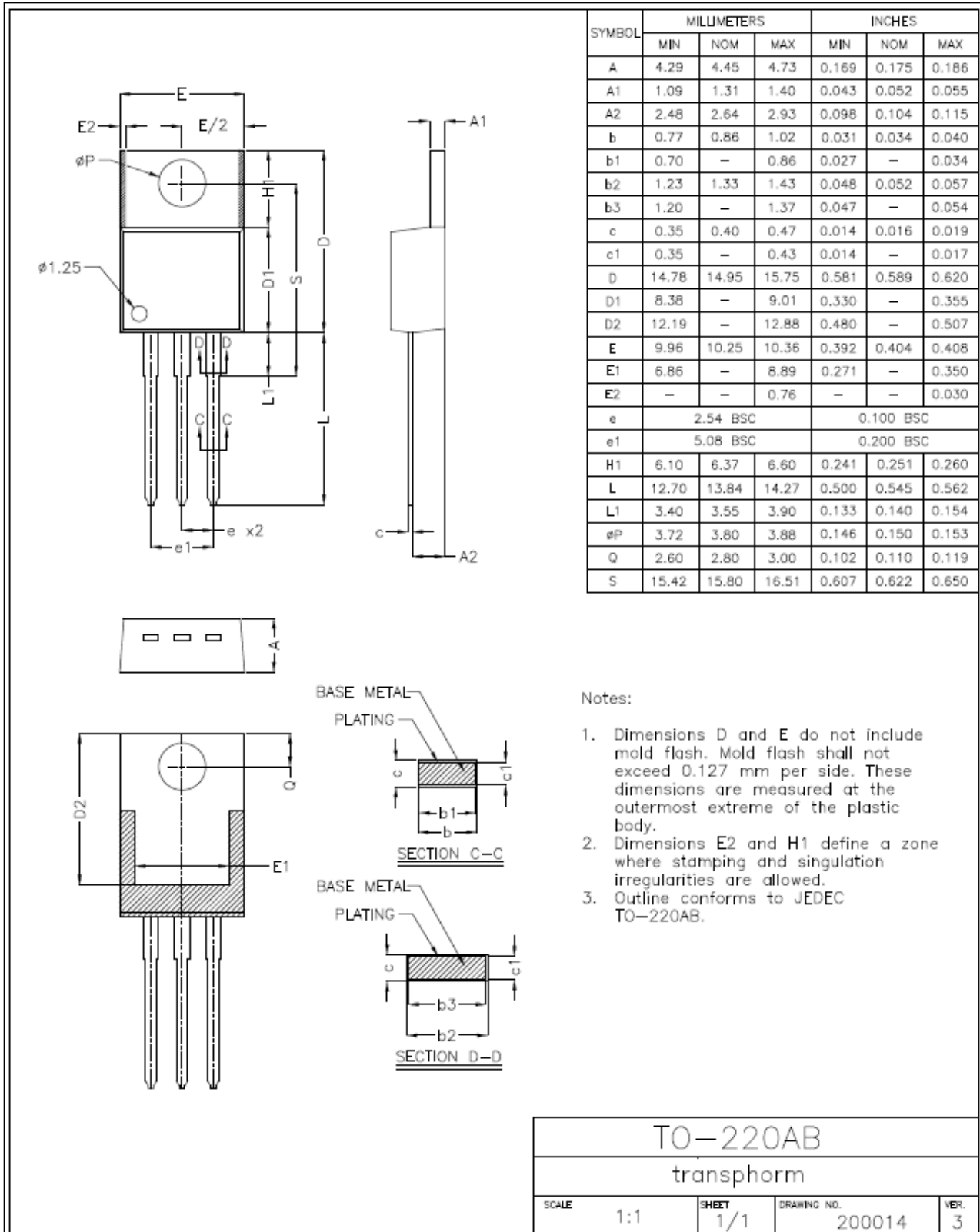
- Reference designs
- Evaluation kits
- Application notes
- Design guides
- Simulation models
- Technical papers and presentations

TP90H180PS

Mechanical

3 Lead TO-220 (PS) Package

Pin 1: Gate; Pin 2: Source; Pin 3: Drain, Tab: Source



TP90H180PS

Revision History

Version	Date	Change(s)
0	11/10/2017	Release final datasheet